Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10769786	CHOI ET AL.	
Examiner	Art Unit	
Nguyen, Jennifer T	2629	

SEARCHED							
Class	Subclass	Date	Examiner				
345	60-72,88-104	3/17/07	, JN				

SEARCH NOTES						
Search Notes	Date	Examiner				
east, iEEE, JPO	3/17/07	JN				

INTERFERENCE SEARCH								
Class	S	Subclass	Date	Examiner				
315	169.1,169.4		3/17/07	JN				